



Capitalizing on the Benefits of Alternate Grade Electronics through Informed Risk

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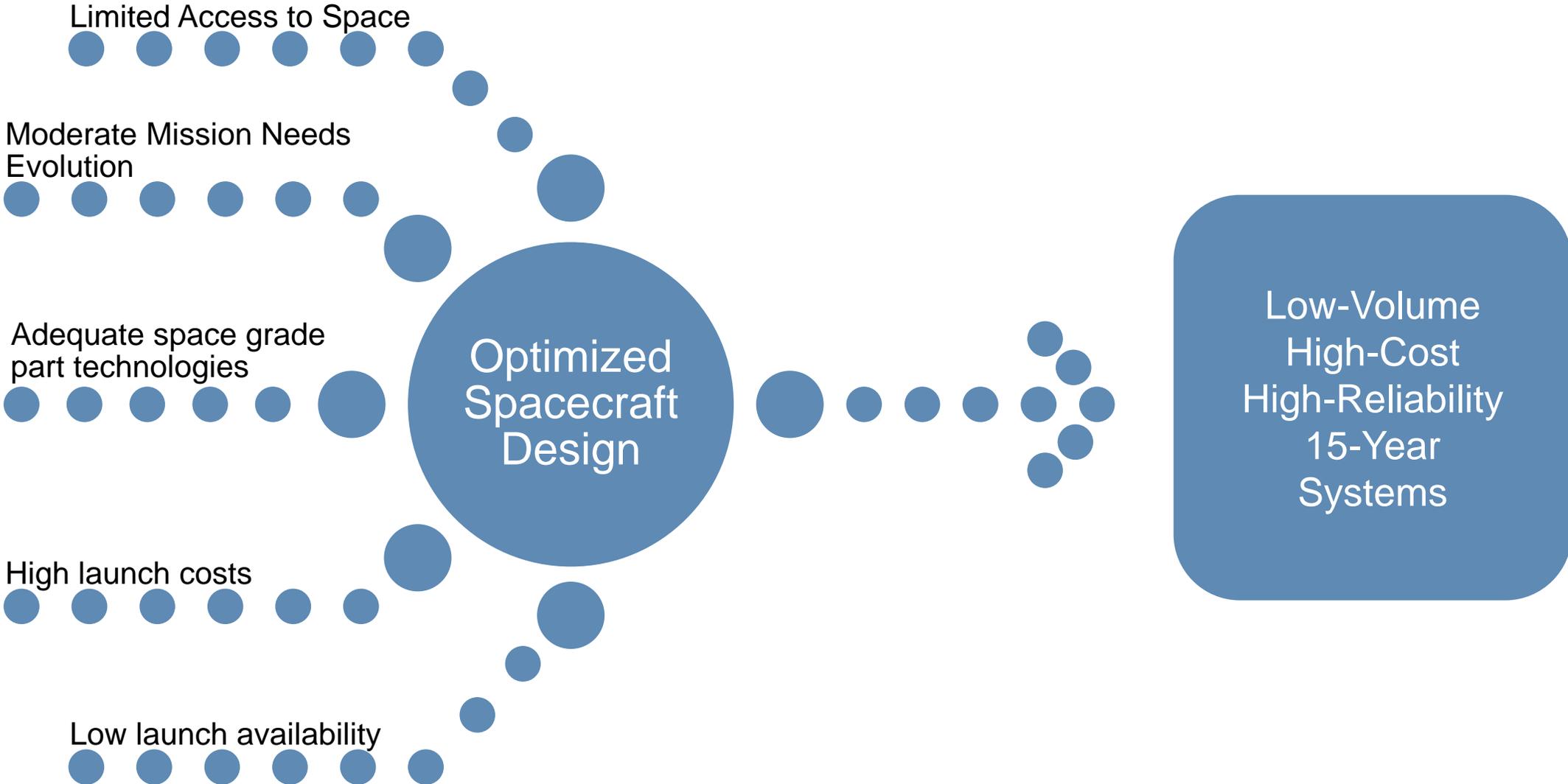
Agenda



- Evolution of Space Systems Needs
- Need for Alternate Grade Electronics
- Enablers for Broader Alternate Grade Electronics Utilization
- How we can help enable
- Questions

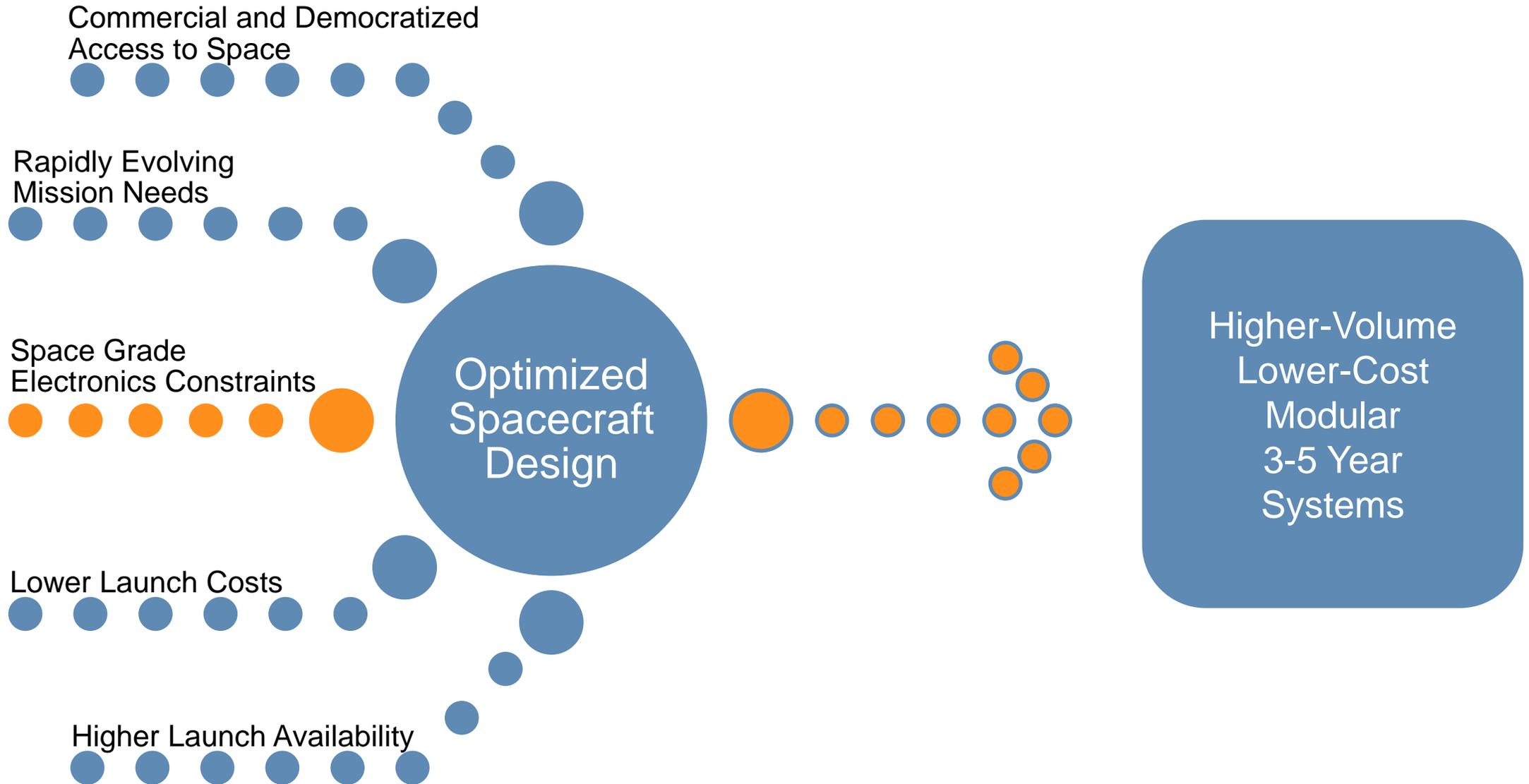


Historical Space Systems Model





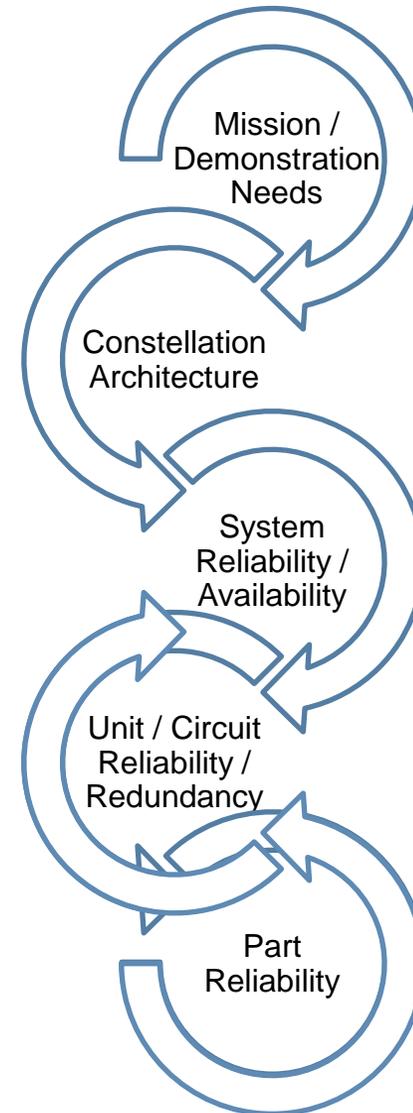
Evolving Space Systems Model





Enablers for Broader Alternate Grade Electronics Utilization

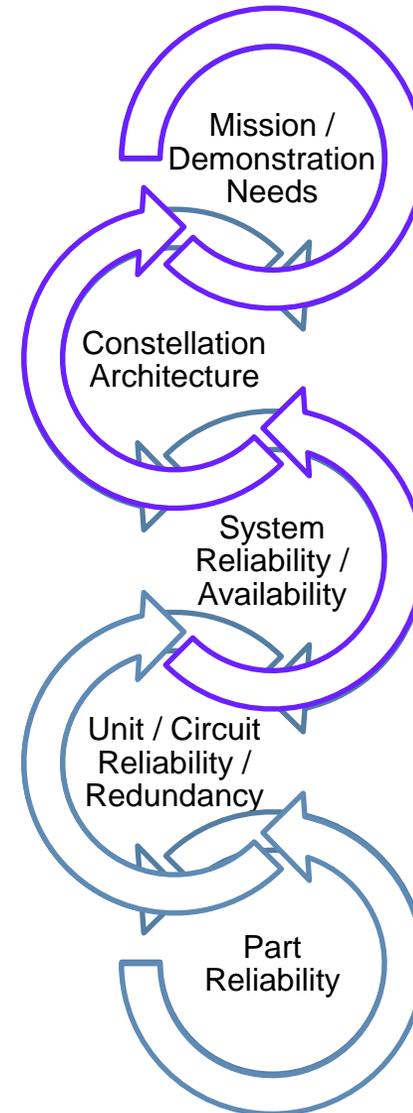
- Historically, most space systems utilized space grade parts
 - *Stringent requirements to ensure high confidence reliability*
 - *Accepted lag from commercial State-of-the-Art technologies*
- Limited use of alternate grade parts
 - *Higher risk missions with “up-screening”*
 - *Demonstrations and prototypes*





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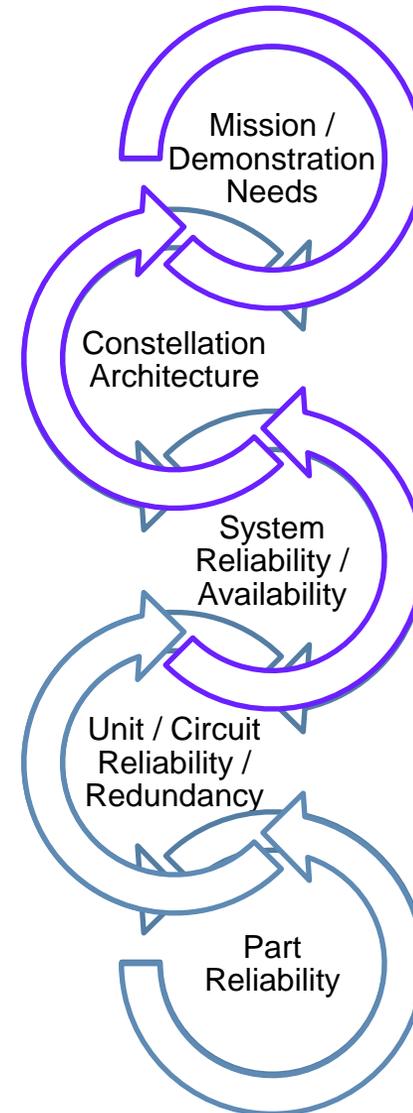
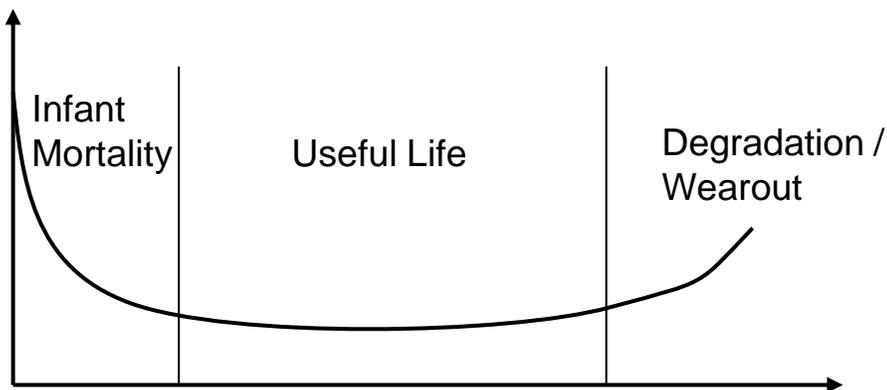
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 - *Higher risk missions with “up-screening”*
 - *Demonstrations and prototypes*
- Evolving mission needs and lower price points driving the potential to utilize alternate grade electronics, but requires...
 - *Sufficient confidence for informed risk management*
 - Avoidance of infant mortality failures
 - Known and consistent performance and failure modes
 - Knowledge of single event effect susceptibilities





Why Alternate Grade Electronics?

- Demand for state-of-the-art technology and reduced development cycles in today's space systems
 - *Commercial business case viability*
 - *US Government rapidly evolving missions and threats*
- Enabled by high volume, affordable and reliable alternate grade EEE global supply chain
 - *Alternate grade electronics include:*
 - Automotive, Aviation, Commercial off the Shelf (COTS), Industrial, Terrestrial Military
 - Piece parts, components and assemblies, subsystems
- Ability to manage risk at higher levels within mission architectures



What can we (the industry) do to accelerate alternate part utilization?

Provide information for informed risk-based decisions

- Leverage existing data and knowledge
 - *Comparison of standards/guidance to identify potential risk and inform mitigation options*
 - A Qualitative Comparison of EEE (Electrical, Electronic, Electromechanical) Component Requirements: Part I – MIL-PRF (Military Performance) vs AEC (Automotive Electronics Council) Standards - OTR-2020-00603
 - A Quick Reference Sheet for Risk-Tolerant Space Missions Using Alternate Grade Electronics – OTR- 2019-01255
 - *Pooling and sharing of data and experience*
 - Non-space industry data and experience
 - Additional part/electronics test data and analysis
 - *Space environment Single Event Effects (SEE) test data and guidance*

• PMPedia.space	vanguard.isde.vanderbilt.edu/RGentic/	s3vi.ndc.nasa.gov	https://schema.space
• spoonsite.com	creme.isde.vanderbilt.edu	modelbasedassurance.org	
 - *Up-screening and On-orbit experience*
- Develop new innovative, efficient and cost-effective approaches to Incorporate features, guidelines and data mining in part design/manufacture to reduce backend testing
 - *New approaches to mitigate the introduction of new infant mortality, wearout and SEE mechanisms*
 - *More efficient and perceptive test approaches*
 - *Early characterization to inform redundancy trades for achieving reliability and availability needs*



Questions?